SYNC ANALYZER

8080

FTB-8080

IIII NETWORK TESTING



Fast, Easy Synchronization Testing for SDH, PDH and SONET Networks

- Measures wander on transmission rates from 4 kHz to 52 Mb/s—the most cost-effective wander measurement tool available
- The easiest tool in its category: fool-proof operation
- Frees up your expensive, all-inclusive testers for more complex applications
- Control the unit and retrieve data from anywhere (Ethernet access)
- MTIE and TDEV masks
- Portable 2.048/1.544 MHz clock generator



Speeding Up Synchronization Testing of Telecom Networks

Incorrect synchronization in digital communication networks can cause severe transmission problems. Voice calls (fixed or cellular) will be lost, fax machines will misprint, and data will be lost or frequently retransmitted. In any case, network performance is degraded, the operators' service costs are increased and revenues are down.

The main cause for synchronization problems in transport networks is wander of the synchronization clock. Quality control of the synchronization clock requires monitoring of wander over a long period (hours or days), using an ultra-stable clock as a reference.

To date, wander measurement has involved bulky, complex and very expensive instrumentation. Until now, viewing MTIE and TDEV wander parameters specified in international standards often required external rubidium standards and/or external computers.

EXFO's FTB-8080 advanced synchronization analyzer solves this problem. It enables multi-application synchronization testing at a multitude of data rates in SDH, PDH, SONET, wireless video and frequency reference distribution networks.



The FTB-8080 enables synchronization testing at various data rates in SDH, PDH, SONET, video and frequency reference distribution networks.

Wander Measurement: Network Applications

- Confirmation of network synchronization during installation and commissioning
- Verification of clock quality when sync services are sold
- Synchronization qualification after network topology changes
- Preventive monitoring installations

Wander Measurement: Lab/Manufacturing Applications

- Network simulation, device characterization and production testing
- Quality control and incoming inspection of network hardware

KEY FEATURES

- Display of TIE, MTIE and TDEV, as well as comparison with standard masks
- E1 clock/data signals (2 Mb/s)
- Transmission rates from 4 kHz to 52 Mb/s (E3, DS-1, DS-3, STS-1, STM-0)
- 2048 kHz portable synchronization E1 clock; 1544 kHz portable synchronization T1 clock
- Internal rubidium reference with GPS input for field calibration
- No external PC needed
- Ethernet interface for remote control and data access
- 110, 220 AC and -48 V DC supply
- Differential and absolute wander measurement
- Displays frequency offset of local clocks

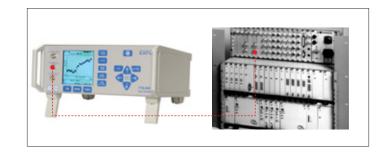
Performing Standardized Measurements

EXFO's FTB-8080 Sync Analyzer is designed to measure wander according to ITU and ANSI standards of various signals in SONET, SDH or PDH network nodes, with graphical presentation of TIE, MTIE and TDEV and comparison to standard masks (e.g., PRC, SSU, SEC). It enables the creation of user-defined masks, according to new or changed standards, for easy recall during measurements.

The FTB-8080 can measure both "absolute" and "differential" wander. In the first case, the measured signal (clock or data) is compared to the ultimate stability of the internal rubidium "atomic" clock or an external 10 MHz reference. In the second case, the relative wander between two signals (e.g., ingoing and outgoing E1 signal from a network element) is measured. This makes it possible to verify wander tolerance and the amount of "extra wander" created by the device under test.

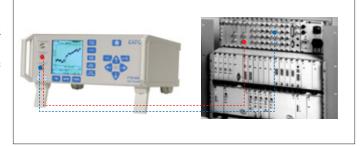
Absolute Wander

- Measure absolute wander in sync equipment and network elements
- Use the internal rubidium clock as a reference, or...
- Use GPS satellite synchronization to compare multiple sites with a single reference; correlate with SyncView software



Differential Wander

- Measure differential wander in/out of sync equipment and network elements
- Using the incoming sync signal as reference for the outgoing sync signal
- Pinpoint wander added by equipment or network elements



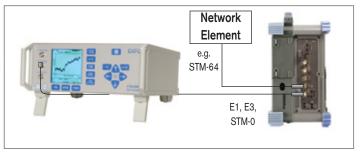
Supported Input Rates

SONET/SDH 52 Mb/s	STM-0E/STS-1	Other Rates 4 kHz 8 kHz
PDH/DSn 2.048 MHz/Mb/s 34 Mb/s 64 Kb/s	E1 E3 DS0	Video — 27 MHz — 15.750 kHz NTSC H-sync — 15.625 kHz PAL H-sync
1.544 MHz/Mb/s 45 Mb/s	DS1 / T1 DS3	Reference Frequencies 10 MHz Calibration input/output 2.048 MHz E1 clock output 1.544 MHz T1 clock output

Connecting the FTB-8080 with EXFO's FTB-8000/ FTB-8100 SONET/SDH Analyzers

Use the FTB-8000 or FTB-8100 SONET/SDH Analyzers for measuring wander at rates not supported by the the Sync Analyzer

- The sync clock is common at all rates within a payload
- The wander measured from a dropped rate is the same as the original (e.g., when extracting E1 from an STM-64, the wander on E1 and STM-64 are the same)



Remote Control Via Internet

EXFO's FTB-8080 is a compact, lightweight, self-contained instrument that features a built-in rubidium reference clock and a graphical display. There is no need to carry around an external frequency standard or a separate PC to make and view the measurement. A PC cable and 120 W to 75 W transformers come standard, to enable measurement on any kind of cable system, whether 75 W unbalanced or 120 W balanced. An Ethernet interface, a 1.544/2.048 MHz clock and a -48 V DC voltage supply also come standard.

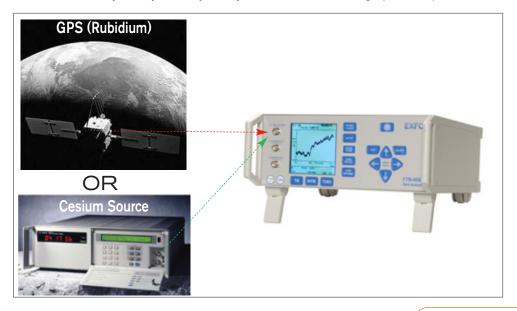
Easy to Operate and Calibrate

The FTB-8080 is very easy to use and can be easily operated by unskilled personnel. For standard measurements, only a few keystrokes are required. Once the measurement is started, the unit can be left unattended for automatic measurements, and can be configured to automatically start and stop at preset times.

A fully automatic signal check informs the user whether he/she has connected the right signal from the rack. Online context-sensitive help is also available.

The calibration and adjustment of the internal rubidium clock is simple and fully automated. Connect a known reference signal from a cesium or a GPS-controlled rubidium clock, enter the calibration mode of the Sync Analyzer, and leave the unit overnight. The next morning, the FTB-8080 is perfectly adjusted, without any manual trimming required.

EXFO's FTB-8080 Sync Analyzer is easy to carry, with side handles and a flight-proof transport case (extra accessory).



Automatic Adjustment of the Rubidium Clock

- Connect to a frequency reference
- Leave FTB-8080 alone overnight, and...
- The internal rubidium clock is perfectly adjusted!

Built for User-Friendliness

Automatic signal check

Eliminates measurement on wrong signal

Unattended operation

Starts and stops as programmed

Graphical display

Immediate, easy-to-read visual feedback

Context-sensitive help

No need to read the user guide

Ethernet connection

Fast, easy retrieval of test data

A Complete Unit

Once you have installed the FTB-8080 at one network node location to perform measurements, you do not need to travel back to get the results from individual wander measurements. Via the Ethernet port, you can connect the Sync Analyzer to the Internet. From a central PC running SyncView, you can control the downloading of measurement data and the setup of new measurements.

Working Principle

EXFO's FTB-8080 Sync Analyzer is built in an EMI-proof metal cabinet and contains a rubidium reference and a special in-house-developed time interval error (TIE) measurement circuitry, which phase-compares the connected signal with the rubidium reference. The FTB-8080 communicates its results to the user via a graphical display, and to a PC via an RS-232 port or an Ethernet port.

The FTB-8080 operates in two different modes:

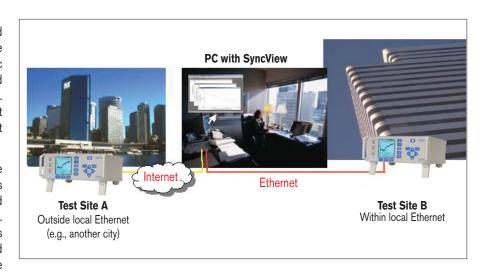
Local mode operation

This is the stand-alone operation mode. During the measurement, the TIE curve on the display is continuously updated, showing the performance of the sync clock "so far". This mode is intended for fully automated diagnosis and/or fault-finding measurement "on-site", with real-time, direct visual feedback. The sampling rate is approximately 1 Sa/s. The Sync Analyzer calculates and presents the MTIE or TDEV curves after the completed TIE measurement, and compares to stored masks.

Remote (PC-controlled) operation

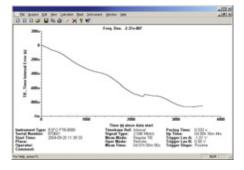
The FTB-8080 can be operated/controlled from the RS-232 port of a PC, running the SyncView PC software. In this mode, the Sync Analyzer acts as a sampling front-end and transfers the TIE values one by one to the PC. The local display of the Sync Analyzer is not updated. There is also an Ethernet port available for the same purpose.

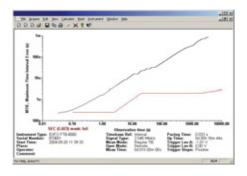
Sampling speed is > 30 TIE values/s, and the storage is only limited by the PC, which means that the fast sampling rate can be maintained during a 24 h period (or longer if required). The PC software calculates and presents MTIE or TDEV curves after completed measurement period, and compares to the defined masks. This mode is intended for verification of conformance to ETSI or ANSI standards.



SyncView Companion Analysis Software

- Windows 95/98/NT/XP
- Reads TIE data from FTB-8080 Sync Analyzer-high-speed, large storage in PC
- Displays and prints calibration records—TIE, MTIE and TDEV graphs
- Programmable user-defined masks-add new/changed MTIE and TDEV standards, or request updated masks from EXFO support
- Remote control-read data via Internet/Ethernet from anywhere in the world





Why Measure Wander?

Too much wander can create various problems, depending on which type of signal it occurs. The result is unreliable network services and reduced, which in turn means higher costs and lower revenues. Here are a few examples of problems caused by high wander:

Fax ⇒ Unreadable charactersVoice ⇒ Sudden click sounds

■ Data ⇒ Retransmission (lower throughput)

— GSM ⇒ Lost calls— ATM ⇒ Lost data

Wander vs. Jitter

Wander measurement and jitter measurement are different applications. One is carried out during network testing, the other during equipment testing. Wander and jitter test functions therefore don't need to be combined in the same unit.

Wander: a network parameter

- Propagates through the network path and increases
- Longer measurement time (typically 24 h)
- May cause total loss of synchronization
- Main cause for synchronization problems

Jitter: an equipment parameter

- Does not propagate in the network and is reduced in network nodes
- Spot measurements
- May cause minor transmission problems

The bottom line: It is wander, not jitter, that is crucial for network synchronization.

SPECIFICATIONS¹

Presentation modes Time interval error (TIE)	Displayed and continuously undated in Local mode	anavation	
	Displayed and continuously updated in Local mode operation.		
MTIE	Calculated from the measured and stored TIE values and displayed after completed measurement in Local mode operation.		
TDEV	Calculated from the measured and stored TIE value	es and displayed after completed measurement in Local mode operation.	
Test modes (MTIE and TDEV mask	c)		
	reference in all modes except "Differential". Mask applies	for MTIE and TDEV graphs.	
Draft	No masks		
PRC	Masks for G811 clock (ETS 300 462-3)		
SSU	Masks for G812 clock (ETS 300 462-3)		
SEC	Masks for G813 clock (ETS 300 462-3)		
SSU (locked mode)	Masks for G812 clock (ETS 300 462-4)		
SEC (locked mode)	Masks for G813 clock (ETS 300 462-5)		
ANSI standards	To be defined		
Video	To be defined		
Differential	Relative wander (TIE, MTIE and TDEV) between tw	o clocks or data signals.	
Input signal characteristics			
Frequency	4 kHz, 8 kHz, 64 kb/s, 1.544 MHz, 1.544 Mb/s, 2.		
	27 MHz, 34 Mb/s, 45 Mb/s, 52 Mb/s, 15.750 kHz	(NTSC), 15.625 kHz (PAL)	
Amplitude	Between -5 V and +5 V		
Signal type	Symmetrical pulse (clock signal)	HDB3-coded data (data signal)	
	Unsymmetrical repetitive pulse (clock signal)	AMI B8ZS, B3ZS (data signal)	
Time interval error (TIE)			
Reference clock	Built-in rubidium clock or an external 10 MHz clock	signal connected to external reference input	
Measuring time	Built-in rubidium clock or an external 10 MHz clock signal connected to external reference input 30 min, 2 h, 4 h, 24 h or continuously (Local mode)		
Local mode update rate	55 mm, 2 m, 4 m, 24 m or community (Local mode)		
30 min, 2 h, 4 h	approx. 1 Sa/s		
24 h	approx. 0.2 Sa/s (1 Sa/6s)		
Continuously	16 000/time Sa/s; max. approx. 1 Sa/s. Data compression after approx. 4 h.		
Remote mode update rate		and the second of the second o	
Any measuring time	up to 30 Sa/s		

SPECIFICATIONS¹

Internal data storage Size	16 000 stored TIE values	Type Non-volat	tile storage
UILU	10 000 Stored TIL Values	Typo INUITYUIAI	ino otorago
Measuring time			
Time	Short (30 min, 2 h, 4 h), long (24 h) and continuous		
Start/Stop	Via Start/Stop key		
Warmup time	Selectable delay before measurement starts, to allow the	instrument to warmup properly (0, 30 r	minutes, 4 h or 24 h).
Signal check			
Measures and displays the following parar	neters		
Signal type (clock,		Pulse width (for data signals)	
Frequency (for clo	ck signals)	Voltage peak-peak (min. 120 mVp-p)	
Save/recall			
No. of instrument setups	5		
No. of screen images	3 (TIE, MTIE or TDEV)		
Stored TIE-value array	16 k values (1 set)		
Write protection	Saved setup, screen image or TIE-value array can be pro	tected against accidental overwriting.	
Graph display			
Display modes	TIE, MTIE or TDEV		
Vertical scale	Displayed TIE, MTIE or TDEV value in ns or ms. Auto-scaled.		
Horizontal scale	Real-time axis (TIE) or "t"-axis (MTIE/TDEV). Auto-scaled (continuous measurement and differential test mode) or fixed-scaled (2 h/24 h full scale).		
No. of divisions	Rear-time axis (TE) or 1 -axis (WTTE/TDEV). Auto-scaled (continuous measurement and differential test mode) or fixed-scaled (2 fi/24 fi full scale) 8 x 10 (vert. x horiz.)		
Masks	MTIE and TDEV masks according to selected test mode.		
	g		
Clock/data inputs A and B		External reference input	
Connector	BNC	Connector	BNC
Coupling	DC coupled	Input frequency	10 MHz
Voltage range	± 5.00 V	Voltage range	0.5 Vrms to 6 Vrms
Sensitivity	60 mVpp	Impedance	approx. 500 Ω
Impedance	75 Ω, VSWR < 2:1	Coupling	AC coupled
Maximum input voltage without damage	12 Vrms up to 2 MHz, decreasing to 6 Vrms at 10 MHz	Maximum input voltage without damag	ge 30 Vrms up to 1 kHz, decreasing
Trigger level	Automatically set via Signal Check;		to 6 Vrms at 10 MHz
	can be manually adjusted		
Range	± 5.00 V		
Resolution	10 mV		
Reference frequency output		2.048 MHz clock output	
Connector	BNC	Connector	BNC
Ref. frequency	10 MHz square-wave	Ref. frequency	2.048 MHz square-wave
Frequency stability	See internal timebase stability spec.	Freq. stability	See timebase oscillator specification
Output levels	Fixed TTL: low < 0.4 V, high > 1.8 V into 50 W	Jitter	< 0.01 UI
		Wander	MTIE < 15 ns + t (freq. offset)-1
1.544/2.048 MHz clock output		Output level	According to G703:10; \pm 1.2 V \pm 10 %
Connector	BNC		in 75 W
Ref. frequency	1.544/2.048 MHz square-wave		
Frequency stability	See internal timebase stability specification		
Jitter	< 0.01 UI		
Wander	MTIE < 15 ns + (freq. offset)-1		
Output level	According to G703:10; ± 1.2 V ± 10 % in 75 W		
RS-232 data in/output			
Connector	9-pin male D-Sub connector		
Baud rate	9600 b/s		
Data format	8 data dits, i stod dit. no darity		
Data format Ethernet	8 data bits, 1 stop bit, no parity		
	Connector: RJ45 Protocol: 10Base-T		

SPECIFICATIONS¹

Operating system		Windows 95 / 98 / NT / 2000		
Data transfer		TIE values (real-time or stored	values)	
		Stored graphs		
		Instrument id		
		Setup information		
Calculate functions		MTIE, TDEV		
Instrument control fu	nctions	Local or Remote mode		
		Auto-adjustment of rubidium of	scillator	
		Instrument setup		
Custom mask editor		Unlimited user-defined MTIE+	TDEV mask	
File functions		Document printout, file save/re	etrieve	
		•		
Calibration				
Principle		Closed-case calibration with automatic		
		adjustment of the rubidium timebase		
Calibration reference		Cs-oscillator or GPS-controlled rubidium		
Calibration reference	frequency	100 kHz, 1, 1.544, 2.048, 5 or 10 MHz		
Calibration uncertain	ty (typical)	< 2 x 10 ⁻¹² + calibration refere	nce frequency	
		uncertainty		
Internal timebase	stability			
Aging rate per	•	24 h	< 2 x 10 ⁻¹² (typ.	
		Month	< 5 x 10 ⁻¹¹	
Short-term stability p	er	1 s	< 3 x 10 ⁻¹¹	
, ,		10 s	< 1 x 10 ⁻¹¹	
Warmup stability		10 min	< 4 x 10 ⁻¹⁰	
Factory adjustment u	ncertainty (+23 °C)	± 0.0005 Hz at 10 MHz		
Display				
Type	Super-twisted liqui	id crystal		
Size	84 x 84 mm, 4.7" diagonal			
Resolution (pixels)	240 x 240			
Backlight	Cold cathode fluor	escent (CCFL) tube; brightness	approx. 50 cd/m ²	
Contrast ratio	User-adjustable, max. 1:15 (typical at 20 °C)			

A	O	
General	Specifi	cations

Size (H x W x D)		34.2 cm x 17.7 cm x 30.5 cm
Weight	Net	5 kg (11 lb)
-	Shipping	7 kg (15 lb)
Environmental data	1	•
Temperature	operating	0 °C to 50 °C
	storage	−20 °C to 70 °C
Humidity	operating	20 °C to 30 °C, 90 % RH non-condensing
-		30 °C to 50 °C, 70 % RH non-condensing
	storage	95 % RH
Altitude	operating	3000 m (10 000 ft)
	storage	12 000 m (40 000 ft)

Safety

EN 61010-1:1997, CAT II, pollution degree 2, CE EMC: EN 55022B, EN 61000-6-2, CE

Power supply

Line voltage	100 to 240 Vrms \pm 10 %	
	47 Hz to 63 Hz, < 60 W	
-48 V DC voltage	38 V to 72 V DC, < 60W	

Standard Accessories

Sync Analyzer software for general clock or data signals, AC line power cord, two 120 W to 75 W transformers (BNC mounted), RS-232 PC connection cable, user guide, Certificate of Calibration.

Optional Accessory

Heavy-duty hard carrying case (GP-10-065).

Ordering Information

FTB-8080 Sync Analyzer

Find out more about EXFO's extensive line of high-performance portable instruments by visiting our website at www.exfo.com.



Rugged Handheld Solutions

- OLTS
- -Light source
- Talk set



Optical Fiber

- OTDR
- OLTS
- ORL meter -Switch

DWDM Test Systems

- -OSA
- -PMD analyzer
- -Chromatic dispersion analyzer -Multiwavelength meter

Transport/Datacom

- 10/100 and Gigabit Ethernet
- SONET/DSn (DS0 to OC-192c)
- SDH/PDH (64 kb/s to STM-64c) _SAN

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EXFO is certified ISO 9001 and attests to the quality of these products. This device complies with Part 15 of the FCC Rules. Operation is subject to the following two conditions: (1) this device may not cause harmful interference, and (2) this device must accept any interference received, including interference that may cause undesired operation. EXFO has made every effort to ensure that the information contained in this specification sheet is accurate. However, we accept no responsibility for any errors or omissions, and we reserve the right to modify design, characteristics and products at any time without obligation. Units of measurement in this document conform to SI standards and practices. Contact EXFO for prices and availability or to obtain the phone number of your local EXFO distributor. For the most recent version of this spec sheet, please go to the EXFO website at http://www.exfo.com/specs

